



### **DUAL P-CHANNEL ENHANCEMENT MODE MOSFET**

### **Product Summary**

| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> max        | I <sub>D</sub> max<br>T <sub>A</sub> = +25°C |
|----------------------|--------------------------------|--|
| -20V                 | $75m\Omega$ @ $V_{GS} = -4.5V$ | -4.6A  |
| -20V                 | 110mΩ @ $V_{GS}$ = -2.5 $V$    | -2.9A  |

### **Description**

This MOSFET has been designed to minimize the on-state resistance and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

## **Applications**

- Backlighting
- **Power Management Functions**
- DC-DC Converters

### **Features**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

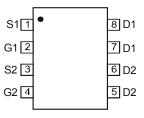
### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram Below
- Marking Information: See Page 4
- Ordering Information: See Page 4
- Weight: 0.072 grams (approximate)

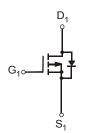
SO-8



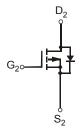
Top View



Top View Internal Schematic



P-Channel MOSFET



P-Channel MOSFET

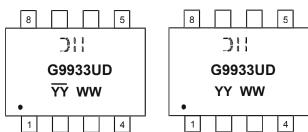
### Ordering Information (Note 4)

| Part Number   | Case | Packaging           |
|---------------|------|---------------------|
| DMG9933USD-13 | SO-8 | 2,500 / Tape & Reel |

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

## **Marking Information**



Shanghai A/T Site

];; = Manufacturer's Marking G9933UD = Product Type Marking Code YYWW = Date Code Marking YY or  $\overline{YY}$  = Year (ex: 14 = 2014) WW = Week (01 - 53)YY = Date Code Marking for SAT (Shanghai Assembly/ Test site) YY = Date Code Marking for CAT (Chengdu Assembly/ Test site)

Chengdu A/T Site



# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

| Characteristic  |                 |  | Symbol           | Value      | Unit |
|---|-----------------|--|------------------|------------|------|
| Drain-Source Voltage                                      | $V_{DSS}$       | -20  | V                |            |      |
| Gate-Source Voltage                                       |                 |  | V <sub>GSS</sub> | ±12        | V    |
| Continuous Drain Current (Note 5) V <sub>GS</sub> = -4.5V | Steady<br>State | T <sub>A</sub> = +25°C<br>T <sub>A</sub> = +85°C | ID               | -4.6<br>-3 | А    |
| Pulsed Drain Current (Note 6)                             |                 |  | I <sub>DM</sub>  | -20        | Α    |

# **Thermal Characteristics**

| Characteristic  | Symbol                            | Value       | Unit |
|---|-----------------------------------|-------------|------|
| Power Dissipation (Note 5)                                      | P <sub>D</sub>                    | 1.15        | W    |
| Thermal Resistance, Junction to Ambient @T <sub>A</sub> = +25°C | $R_{\theta JA}$                   | 109         | °C/W |
| Operating and Storage Temperature Range                         | T <sub>J</sub> , T <sub>STG</sub> | -55 to +150 | °C   |

Notes:

- 5. Device mounted on FR-4 PCB, with minimum recommended pad layout.
- 6. Repetitive rating, pulse width limited by junction temperature.

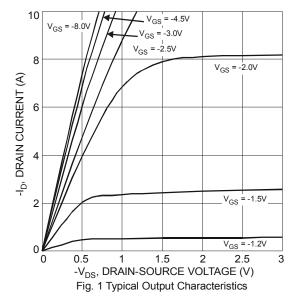
# **Electrical Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

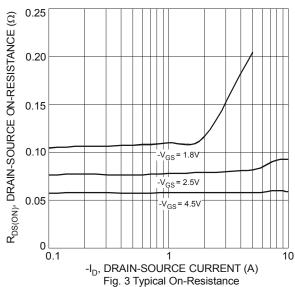
| Characteristic   | Cymphol              | Min   | Turn  | May  | I I mid | Test Condition  |  |
|--|----------------------|-------|-------|------|---------|---|--|
| Characteristic OFF CHARACTERISTICS (Note 7)            | Symbol               | Min   | Тур   | Max  | Unit    | rest Condition  |  |
| , ,  | D) (                 | - 00  | 1     | l    |         | lv 01/1 050 A   |  |
| Drain-Source Breakdown Voltage                         | BV <sub>DSS</sub>    | -20   | _     | _    | V       | $V_{GS} = 0V, I_D = -250\mu A$  |  |
| Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C | I <sub>DSS</sub>     | _     | _     | -1   | μΑ      | $V_{DS} = -16V, V_{GS} = 0V$  |  |
| Gate-Source Leakage                                    | I <sub>GSS</sub>     | _     | _     | ±100 | nA      | $V_{GS} = \pm 12V, V_{DS} = 0V$   |  |
| ON CHARACTERISTICS (Note 7)                            |                      |       |       |      |         |   |  |
| Gate Threshold Voltage                                 | $V_{GS(th)}$         | -0.45 |       | -1.1 | V       | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$   |  |
| Static Dunin Source On Besistance                      | _                    | _     | 55    | 75   | 0       | $V_{GS} = -4.5V$ , $I_D = -4.8A$  |  |
| Static Drain-Source On-Resistance                      | R <sub>DS (ON)</sub> | _     | 76    | 110  | mΩ      | V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -1A   |  |
| Forward Transfer Admittance                            | Y <sub>fs</sub>      | _     | 10    | _    | S       | $V_{DS} = -9V, I_{D} = -3.4A$   |  |
| Diode Forward Voltage                                  | $V_{SD}$             | _     | -0.8  | -1.2 | V       | $V_{GS} = 0V, I_{S} = -2A$  |  |
| DYNAMIC CHARACTERISTICS (Note 8)                       |                      | _     | _     | _    | _       |   |  |
| Input Capacitance                                      | C <sub>iss</sub>     | _     | 608.4 | _    | pF      | .,  |  |
| Output Capacitance                                     | Coss                 | _     | 81.5  | _    | pF      | $V_{DS} = -6V, V_{GS} = 0V$<br>- f = 1MHz   |  |
| Reverse Transfer Capacitance                           | C <sub>rss</sub>     | _     | 72.4  | _    | pF      | 1 - 1101112   |  |
| Gate Resistance  | $R_{g}$              | _     | 44.91 | _    | Ω       | $V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$  |  |
| Total Gate Charge                                      | $Q_g$                | _     | 6.5   | _    | nC      | V <sub>DS</sub> = -10V, V <sub>GS</sub> = -4.5V,<br>I <sub>D</sub> = -3.2A                |  |
| Gate-Source Charge                                     | $Q_{gs}$             |       | 0.9   | _    | nC      |   |  |
| Gate-Drain Charge                                      | $Q_{gd}$             | _     | 1.5   | _    | nC      | ID = -3.2A  |  |
| Turn-On Delay Time                                     | t <sub>D(on)</sub>   | _     | 12.45 | _    | ns      |   |  |
| Turn-On Rise Time                                      | t <sub>r</sub>       | _     | 10.29 | _    | ns      | $V_{DS}$ = -10V, $V_{GS}$ = -4.5V, $R_L$ = 10 $\Omega$ , $R_G$ = 1 $\Omega$ , $I_D$ = -1A |  |
| Turn-Off Delay Time                                    | $t_{D(off)}$         | _     | 46.52 | _    | ns      |   |  |
| Turn-Off Fall Time                                     | t <sub>f</sub>       | _     | 22.19 | _    | ns      |   |  |

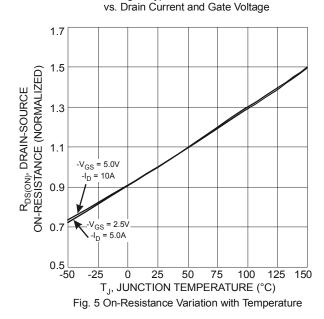
Notes:

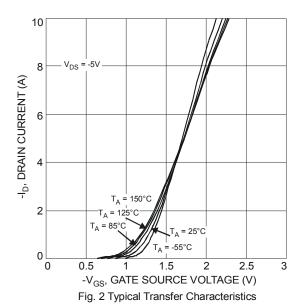
- 7. Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to production testing.











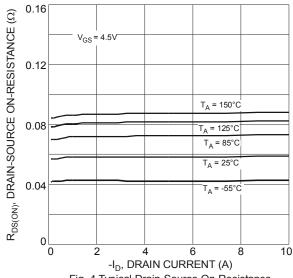


Fig. 4 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

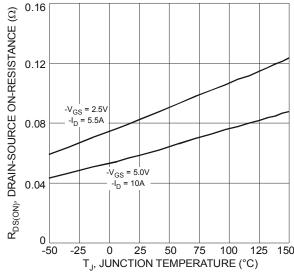


Fig. 6 On-Resistance Variation with Temperature



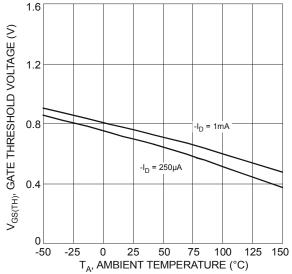
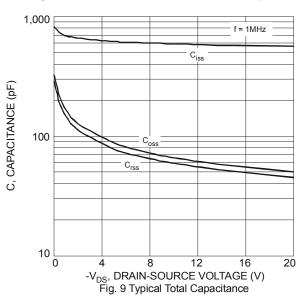
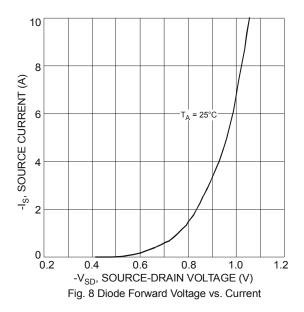
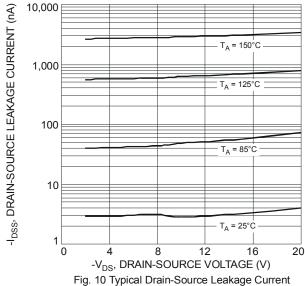


Fig. 7 Gate Threshold Variation vs. Ambient Temperature







vs. Drain-Source Voltage

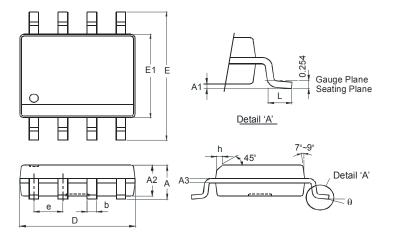
r(t), TRANSIENT THERMAL RESISTANCE  $R_{\theta JA}(t) = r(t) * R_{\theta JA}$   $R_{\theta JA} = 156^{\circ}C/W$ D = 0.020.01 t<sub>2</sub> D = 0.005  $T_J - T_A = P * R_{\theta JA}(t)$ Duty Cycle, D =  $t_1/t_2$ 0.001 0.0001 0.001 0.1 10 100 1,000  $t_1$ , PULSE DURATION TIME (s)

Fig. 11 Transient Thermal Response



# **Package Outline Dimensions**

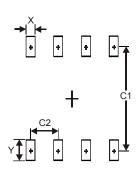
Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



| SO-8                 |          |      |  |  |  |
|----------------------|----------|------|--|--|--|
| Dim                  | Min      | Max  |  |  |  |
| Α                    |          | 1.75 |  |  |  |
| A1                   | 0.10     | 0.20 |  |  |  |
| A2                   | 1.30     | 1.50 |  |  |  |
| A3                   | 0.15     | 0.25 |  |  |  |
| b                    | 0.3      | 0.5  |  |  |  |
| D                    | 4.85     | 4.95 |  |  |  |
| Е                    | 5.90     | 6.10 |  |  |  |
| E1                   | 3.85     | 3.95 |  |  |  |
| е                    | 1.27 Typ |      |  |  |  |
| h                    | -        | 0.35 |  |  |  |
| L                    | 0.62     | 0.82 |  |  |  |
| θ                    | 0°       | 8°   |  |  |  |
| All Dimensions in mm |          |      |  |  |  |

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



| Dimensions | Value (in mm) |
|------------|---------------|
| Х          | 0.60          |
| Υ          | 1.55          |
| C1         | 5.4           |
| C2         | 1.27          |



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